

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/779,336	HIGUCHI ET AL	
Examiner	Art Unit	
MARK A. MAIS	2467	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	254-256 310 312	1/11/2010	MAM
	313 328 329	1/11/2010	MAM
	335 336 338	1/11/2010	MAM
	342 345 347	1/11/2010	MAM
	352 386 388	1/11/2010	MAM
	389 390 392	1/11/2010	MAM
	395.1 396	1/11/2010	MAM
	395.21 400	1/11/2010	MAM
	408 422 429	1/11/2010	MAM
	464 467	1/11/2010	MAM

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
Search P	erformed	1/11/2010	MAM

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
See InventorshipSearch/See Attached Electronic Search	12/11/2007	MAM
See Attached Electronic Search [updated]	8/11/2008	MAM
See Attached Electronic Search [updated]	1/20/2009	MAM
See Attached Electronic Search [updated]	8/28/2009	MAM
See Attached Electronic Search [updated]	1/11/2010	MAM
See Interference Search	1/11/2010	MAM